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SPECIFICATIONS

Customer		
Product Name	Multi-layer Chip Ferrite Bead	
Sunlord Part Number	GZ0603U Series	
Customer Part Number		
New Released, 🗌 Rev	ised] SPEC No.: GZ0203210000	
[This SPEC is total 9 pages including specifications and appendix.]		

[ROHS, Halogen-Free and SVHC Compliant Parts]

Approved By	Checked By	Issued By

Shenzhen Sunlord Electronics Co., Ltd.

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Verified By	Re-checked By	Checked By
	Verified By	Verified By Re-checked By

[Version change history]

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01	/	New release	New products	Guo hai

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Categories: general confidential

Specifications for Multi-layer Chip Ferrite Bead

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[Caution]

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

- 1. Aircraft equipment
- 2. Aerospace equipment
- 3. Undersea equipment
- 4. nuclear control equipment
- 5. military equipment
- 6. Power plant equipment
- 7. Medical equipment
- 8. Transportation equipment (automobiles, trains, ships, etc.)
- 9. Traffic signal equipment
- 10. Disaster prevention / crime prevention equipment
- 11. Data-processing equipment
- 12. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above

External Dimensions

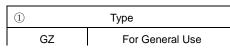
1. Scope

2)

This specification applies to GZ 0603U Series of multi-layer ferrite chip bead.

Product Description and Identification (Part Number) 2.

- Description: 1)
 - GZ0603U Series of multi-layer ferrite chip bead.
 - Product Identification (Part Number) <u>GZ</u> 0603 U <u>121</u> Τ F
 - 1 2 3 4 5 6



3	Material Code	
	U	

5	Packing	
т	Tape Carrier Package	

	-	
	Example	
6 HSF Products	300	
Hazardous Substance Free Products	121	1

2

0603 [0201]

4	Nominal Impedance		
	Example		Nominal Value
	300		30Ω
	121		120Ω

(L X W)[mm]

0.6 X 0.3

Electrical Characteristics 3.

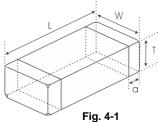
6)

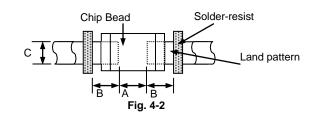
Please refer to Appendix A (Page 8~16).

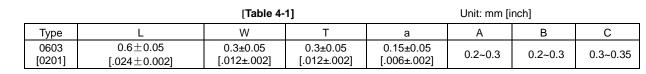
- Operating and storage temperature range (individual chip without packing): -55 $^\circ\!\mathrm{C}$ ~ +125 $^\circ\!\mathrm{C}.$ 1)
- 2) Storage temperature range (packaging conditions):-10℃~+40℃ and RH 70% (Max.)

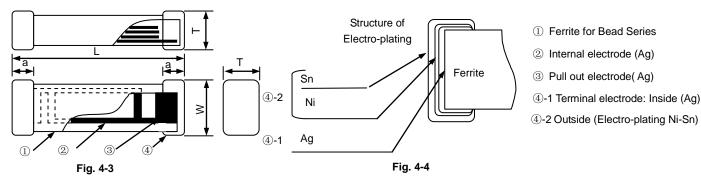
4. Shape and Dimensions

- Dimensions and recommended PCB pattern for reflow soldering: See Fig.4-1, Fig.4-2 and Table 4-1. 1)
- 2) Structure: See Fig. 4-3 and Fig. 4-4









3) Material Information: See **Table 4-2**.

[Table 4-2]

Code	Part Name	Material Name
1	Ferrite Body	Ferrite Powder
2	Inner Coils	Silver Paste
3	Pull-out Electrode (Ag)	Silver Paste
④-1	Terminal Electrode: Inside Ag	Termination Silver Composition
④-2	Electro-Plating: Ni/Sn plating	Plating Chemicals

5. Test and Measurement Procedures

5.1 Test Conditions

5.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

- a. Ambient Temperature: 20±15°C
- b. Relative Humidity: 65±20%
- c. Air Pressure: 86kPa to 106kPa
- 5.1.2 If any doubt on the results, measurements/tests should be made within the following limits:
 - a. Ambient Temperature: 20±2℃
 - b. Relative Humidity: 65±5%
 - c. Air Pressure: 86kPa to 106kPa

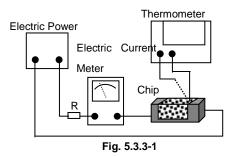
5.2 Visual Examination

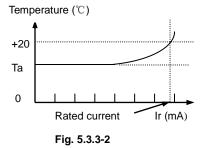
a. Inspection Equipment: 20x magnifier

5.3 Electrical Test

5.3.1 DC Resistance (DCR)

- a. Refer to Appendix A.
- b. Test equipment (Analyzer): High Accuracy Milliohmmeter-HP4338B or equivalent.
- 5.3.2 Impedance (Z)
 - a. Refer to Appendix A.
 - Test equipment: High Accuracy RF Impedance /Material Analyzer-E4991A or equivalent. Test fixture: HP16197A for 0603, HP16192A for 1005/1608/2012/3216. Test signal: -20dBm or 50mV
 - c. Test frequency refers to Appendix A.
- 5.3.3 Rated Current
 - a. Refer to Appendix A.
 - b. Test equipment (see Fig.5.3.3-1): Electric Power, Electric current meter, Thermometer.
 - c. Measurement method (see Fig. 5.3.3-1):
 - 1. Set test current to be 0 mA.
 - 2. Measure initial temperature of chip surface.
 - 3. Gradually increase voltage and measure chip temperature for corresponding current.
 - d. Definition of Rated Current (Ir): Ir is direct electric current as chip surface temperature rose just 20°C against chip initial surface temperature (Ta) (see Fig. 5.3.3-2)





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Items	Requirements	Test Methods and Remarks	
5.4.1 Terminal Strength	No removal or split of the termination or other defects shall occur. Chip Glass Epoxy Board Fig.5.4.1-1	 Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.1-1) using leadfree solder. Then apply a force in the direction of the arrow. 2N force for 0603 series, Keep time: 10±1s. Speed: 1.0mm/s. 	
5.4.2 Resistance to Flexure	No visible mechanical damage.Unit: mm [inch]Typeabc0603[0201]0.250.80.3	 Solder the bead to the test jig (glass epoxy board shown in Fig. 5.4.2-1) Using a leadfree solder. Then apply a force in the direction shown Fig. 5.4.2-2. Plexure: 2mm. Pressurizing Speed: 0.5mm/sec. Keep time: 30 sec. 	
	b ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓	20 R230 45[1.772] Flexure Fig. 5.4.2-2	
5.4.3 Vibration	 No visible mechanical damage. Impedance change: within ±20% Cu pad Solder mask Glass Epoxy Board Fig. 5.4.3-1 	 Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.3-1) using leadfree solder. The bead shall be subjected to a simple harmonic motion having total amplitude of 1.5 mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions (total of 6 hours). 	
5.4.4 Dropping	 No visible mechanical damage. Impedance change: within ±20%. 	Drop chip bead 10 times on a concrete floor from a height of 100 cm.	
5.4.5 Temperature	Impedance change should be within $\pm 20\%$ of initial value measuring at $20^{\circ}C$.	Temperature range: -55°C ~ 125°C. Reference temperature: +20°C.	
5.4.6 Solderability	 No visible mechanical damage. Wetting shall exceed 75% coverage for 0603 series; exceed 95% for others 	 Solder temperture:240±2℃ Duration: 3 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. 	
5.4.7 Resistance to Soldering Heat	 No visible mechanical damage. Wetting shall exceed 75% coverage for 0603 series; exceed 95% for others Impedance change: within ±20%. 	 Solder temperature :260±3°C Duration: 5 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. The chip shall be stabilized at normal condition for 1~2 hours before measuring. 	

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		1
5.4.8	① No mechanical damage.	① Temperature, Time: (See Fig.5.4.8-1)
Thermal Shock	② Impedance change: Within ±20%.	-55 $^{\circ}$ C for 30±3 min→125 $^{\circ}$ C for 30±3min.
		② Transforming interval: Max. 20 sec.
	30 min. 30 min.	③ Tested cycle: 100 cycles.
	Ambient	④ The chip shall be stabilized at normal condition for 1~2 hours
	Ambient	before measuring.
	Temperature 30 min.	
	-55°C	
	Fig. 5.4.8-1 ^{20sec.} (max.)	
5.4.9	 No mechanical damage. 	① Temperature: -55±2℃
Resistance to	② Impedance change: within ±20%.	② Duration: 1000 ⁺²⁴ hours.
Low		③ The chip shall be stabilized at normal condition for 1~2 hours
Temperature		before measuring.
5.4.10	① No mechanical damage.	① Temperature: 125±2℃
Resistance to	② Impedance change: within ±20%.	② Duration: 1000 ⁺²⁴ hours.
High		③ The chip shall be stabilized at normal condition for 1~2 hours
Temperature		before measuring.
5.4.11	① No mechanical damage.	① Temperature: 60±2°C
Damp Heat	② Impedance change: Within ±20%.	② Humidity: 90% to 95% RH.
(Steady States)		③ Duration: 1000 ⁺²⁴ hours.
		④ The chip shall be stabilized at normal condition for 1~2 hours
		before measuring.
5.4.12	1 No visible mechanical damage.	1 Temperature: 60±2°C
Loading Under	2 Impedance change: within ±20%.	2 Humidity: 90% to 95% RH.
Damp Heat		
		 4 Applied current: Rated current.
		5 The chip shall be stabilized at normal condition for 1~2 hours
		before measuring.
5 4 4 2		
5.4.13	No visible mechanical damage.	① Temperature: 125±2℃
Loading at High	② Impedance change: within ±20%.	 Duration: 1000⁺²⁴ hours. Applied surgery Deleted surgery
Temperature		 Applied current: Rated current. The abia shall be at billion of a second current in the second current.
(Life Test)		④ The chip shall be stabilized at normal condition for 1~2 hours
		before measuring.

6. Packaging, Storage

6.1 Packaging

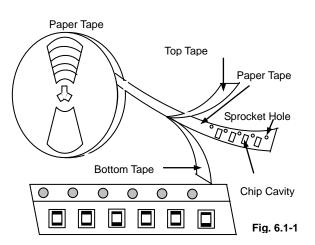
Tape Carrier Packaging:

Packaging code: T

- a. Tape carrier packaging are specified in attached figure Fig.6.1-1~3
- b. Tape carrier packaging quantity please see the following table:

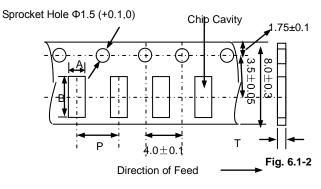
Туре	0603[0201]		
T(mm)	0.3±0.15		
Таре	Paper Tape		
Quantity	15K		

(1) Taping Drawings (Unit: mm)



Remark: The sprocket holes are to the right as the tape is pulled toward the user.

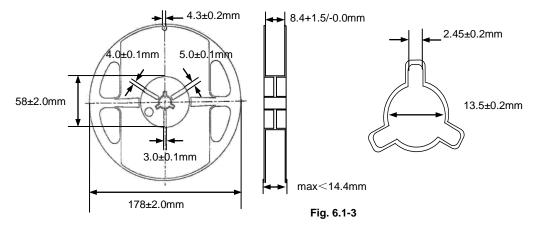
(2) Taping Dimensions (Unit: mm)



Paper Tape

Туре	А	В	Р	T max
0603[0201]	0.40±0.1	0.70±0.1	2.0±0.1	0.55

3) Reel Dimensions (Unit: mm)



6.2 Storage

- a. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Package must be stored at 40°C or less and 70% RH or less.
- b. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCl, sulfurous gas of H₂S).
- c. Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- d. Solderability specified in **Clause 5.4.6** shall be guaranteed for 6 months from the date of delivery on condition that they are stored at the environment specified in **Clause 3**. For those parts, which passed more than 6 months shall be checked solder-ability before use.

7. Recommended Soldering Technologies

7.1 Re-flowing Profile:

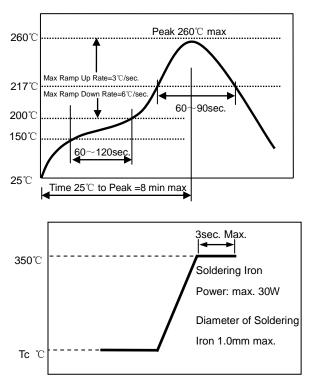
- \bigtriangleup Preheat condition: 150 ~200 $^\circ\!\mathrm{C}/60\text{~-}120\text{sec.}$
- \triangle Allowed time above 217°C: 60~90sec.
- △ Max temp: 260°C
- \triangle Max time at max temp: 10sec.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- \triangle Allowed Reflow time: 2x max

[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]

7.2 Iron Soldering Profile.

- \triangle Iron soldering power: Max.30W
- △ Pre-heating: 150 °C / 60sec.
- \triangle Soldering Tip temperature: 350 °C Max.
- \triangle Soldering time: 3sec Max.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- \triangle Max.1 times for iron soldering
- [Note: Take care not to apply the tip of

the soldering iron to the terminal electrodes.]



Appendix A: Electrical Characteristics I. GZ0603U Series of Beads

S200000 Series of Deaus							
Part Number	Impedance (Ω)	Z Test Freq. (MHz)	DCR (Ω) Max.	Ir (mA) Max.	Thickness (mm) [inch]		
GZ0603U100TF	10±5	100	0.1	500			
GZ0603U700TF	70±25%	100	0.4	200			
GZ0603U800TF	80±25%	100	0.4	200	0.3±0.05		
GZ0603U121 TF	120±25%	100	0.5	200	[.012±.002]		
GZ0603U241TF	240±25%	100	0.8	200			
GZ0603U601TF	600±25%	100	1.5	100			
GZ0603U102TF	1000±25%	100	2.5	100			

Impedance Frequency Characteristics

